


<b>Search Notes</b> 	<b>Application/Control No.</b> 10576154	<b>Applicant(s)/Patent Under Reexamination</b> MURAYAMA ET AL.
	<b>Examiner</b> Minh-Loan Tran	<b>Art Unit</b> 2826

SEARCHED			
Class	Subclass	Date	Examiner
257	E33.058, E33.075	9-28-07	EB
257	98, 99, E33.061, E33.075	09/29/08	mlt

SEARCH NOTES		
Search Notes	Date	Examiner
Text search in EAST. Search provided by Minh Tran. See attached	9-28-07	EB
East search, see attached printout	09/29/08	mlt

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
257	98, 99,	09/29/08	mlt

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